

74ACT823 9-Bit D-Type Flip-Flop

General Description

The ACT823 is a 9-bit buffered register. It features Clock Enable and Clear which are ideal for parity bus interfacing in high performance microprogramming systems. The ACT823 offers noninverting outputs and is fully compatible with AMD's Am29823.

Features

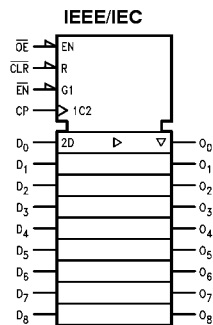
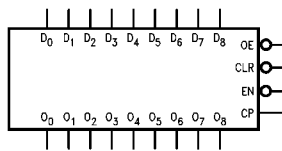
- Outputs source/sink 24 mA
- 3-STATE outputs for bus interfacing
- Inputs and outputs are on opposite sides
- ACT823 has TTL-compatible inputs

Ordering Code:

Order Number	Package Number	Package Description
74ACT823SC	M24B	24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide Body
74ACT823MTC	MTC24	24-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74ACT823SPC	N24C	24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-100, 0.300" Wide

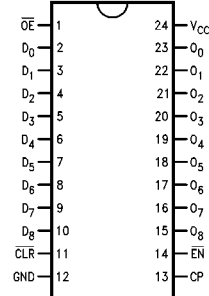
Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code. (SPC not available in Tape and Reel.)

Logic Symbols



Connection Diagram

Pin Assignment
for DIP, SOIC and TSSOP



Pin Descriptions

Pin Names	Description
D ₀ -D ₈	Data Inputs
O ₀ -O ₈	Data Outputs
\overline{OE}	Output Enable
\overline{CLR}	Clear
CP	Clock Input
\overline{EN}	Clock Enable

Functional Description

The ACT823 consists of nine D-type edge-triggered flip-flops. These have 3-STATE outputs for bus systems organized with inputs and outputs on opposite sides. The buffered clock (CP) and buffered Output Enable (\overline{OE}) are common to all flip-flops. The flip-flops will store the state of their individual D-type inputs that meet the setup and hold time requirements on the LOW-to-HIGH CP transition. With \overline{OE} LOW, the contents of the flip-flops are available at the outputs. When \overline{OE} is HIGH, the outputs go to the high impedance state. Operation of the \overline{OE} input does not affect the state of the flip-flops. In addition to the Clock and Out-

put Enable pins, there are Clear (\overline{CLR}) and Clock Enable (\overline{EN}) pins. These devices are ideal for parity bus interfacing in high performance systems.

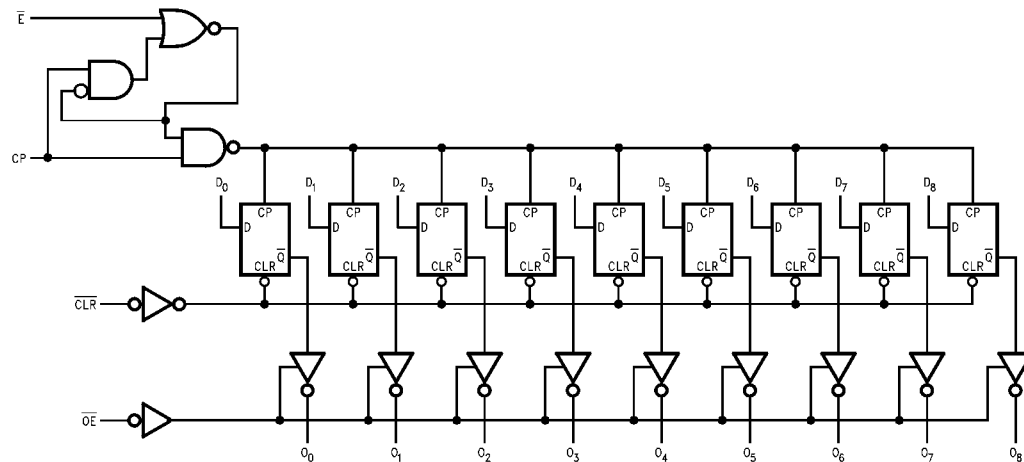
When \overline{CLR} is LOW and \overline{OE} is LOW, the outputs are LOW. When \overline{CLR} is HIGH, data can be entered into the flip-flops. When \overline{EN} is LOW, data on the inputs is transferred to the outputs on the LOW-to-HIGH clock transition. When the \overline{EN} is HIGH, the outputs do not change state, regardless of the data or clock input transitions.

Function Table

Inputs					Internal	Output	Function
\overline{OE}	\overline{CLR}	\overline{EN}	CP	D	Q	O	
H	X	L	↗	L	L	Z	High Z
H	X	L	↗	H	H	Z	High Z
H	L	X	X	X	L	Z	Clear
L	L	X	X	X	L	L	Clear
H	H	H	X	X	NC	Z	Hold
L	H	H	X	X	NC	NC	Hold
H	H	L	↗	L	L	Z	Load
H	H	L	↗	H	H	Z	Load
L	H	L	↗	L	L	L	Load
L	H	L	↗	H	H	H	Load

H = HIGH Voltage Level
 L = LOW Voltage Level
 X = Immaterial
 Z = High Impedance
 ↗ = LOW-to-HIGH Transition
 NC = No Change

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings ^(Note 1)		Junction Temperature (T_J)
Supply Voltage (V_{CC})	-0.5V to 7.0V	PDIP 140°C
DC Input Diode Current (I_{IK})		
$V_I = -0.5V$	-20 mA	
$V_I = V_{CC} + 0.5V$	+20 mA	
DC Input Voltage (V_I)	-0.5V to $V_{CC} + 0.5V$	
DC Output Diode Current (I_{OK})		
$V_O = -0.5V$	-20 mA	
$V_O = V_{CC} + 0.5V$	+20 mA	
DC Output Voltage (V_O)	-0.5V to $V_{CC} + 0.5V$	
DC Output Source or Sink Current (I_O)	± 50 mA	
DC V_{CC} or Ground Current per Output Pin (I_{CC} or I_{GND})	± 50 mA	
Storage Temperature (T_{STG})	-65°C to +150°C	

Recommended Operating Conditions	
Supply Voltage (V_{CC})	4.5V to 5.5V
Input Voltage (V_I)	0V to V_{CC}
Output Voltage (V_O)	0V to V_{CC}
Operating Temperature (T_A)	-40°C to +85°C
Minimum Input Edge Rate ($\Delta V/\Delta t$)	125 mV/ns
V_{IN} from 0.8V to 2.0V	
V_{CC} @ 4.5V, 5.5V	

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation of FACT™ circuits outside databook specifications.

DC Electrical Characteristics

Symbol	Parameter	V_{CC} (V)	$T_A = 25^\circ\text{C}$		$T_A = -40^\circ\text{C to } +85^\circ\text{C}$		Units	Conditions
			Typ	Guaranteed Limits				
V_{IH}	Minimum HIGH Level Input Voltage	4.5	1.5	2.0	2.0	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$	
		5.5	1.5	2.0	2.0			
V_{IL}	Maximum LOW Level Input Voltage	4.5	1.5	0.8	0.8	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$	
		4.5	1.5	0.8	0.8			
V_{OH}	Minimum HIGH Level	4.5	4.49	4.4	4.4	V	$I_{OUT} = -50 \mu A$	
			5.49	5.4	5.4			
V_{OL}	Maximum LOW Level Output Voltage	4.5		3.86	3.76	V	$V_{IN} = V_{IL}$ or V_{IH} $I_{OH} = -24$ mA $I_{OH} = -24$ mA (Note 2)	
		5.5		4.86	4.76			
V_{OL}	Maximum LOW Level Output Voltage	4.5	0.001	0.1	0.1	V	$I_{OUT} = 50 \mu A$	
		5.5	0.001	0.1	0.1			
V_{OL}	Maximum LOW Level Output Voltage	4.5		0.36	0.44	V	$V_{IN} = V_{IL}$ or V_{IH} $I_{OL} = 24$ mA $I_{OL} = 24$ mA (Note 2)	
		5.5		0.36	0.44			
I_{IN}	Maximum Input Leakage Current	5.5		± 0.1	± 1.0	μA	$V_I = V_{CC}, GND$	
I_{OZ}	Maximum 3-STATE Current	5.5		± 0.5	± 5.0	μA	$V_I = V_{IL}, V_{IH}$ $V_O = V_{CC}, GND$	
$I_{CC(T)}$	Maximum I_{CC} /Input	5.5	0.6		1.5	mA	$V_I = V_{CC} - 2.1V$	
I_{OLD}	Minimum Dynamic	5.5			75	mA	$V_{OLD} = 1.65V$ Max	
I_{OHD}	Output Current (Note 3)	5.5			-75	mA	$V_{OHD} = 3.85V$ Min	
I_{CC}	Maximum Quiescent Supply Current	5.5		8.0	80	μA	$V_{IN} = V_{CC}$ or GND	

Note 2: All outputs loaded; thresholds on input associated with output under test.

Note 3: Maximum test duration 2.0 ms, one output loaded at a time.

AC Electrical Characteristics								
Symbol	Parameter	V _{CC} (V) (Note 4)	T _A = +25°C C _L = 50pF			T _A = -40°C to +85°C C _L = 50 pF		Units
			Min	Typ	Max	Min	Max	
f _{max}	Maximum Clock Frequency	5.0	120	158		109	MHz	
t _{PLH}	Propagation Delay CP to O _n	5.0	1.5	5.5	9.5	1.5	10.5	ns
t _{PHL}	Propagation Delay CP to O _n	5.0	2.0	5.5	9.5	1.5	10.5	ns
t _{PHL}	Propagation Delay $\overline{\text{CLR}}$ to O _n	5.0	2.5	8.0	13.5	2.0	15.5	ns
t _{PZH}	Output Enable Time $\overline{\text{OE}}$ to O _n	5.0	1.5	6.0	10.5	1.5	11.5	ns
t _{PZL}	Output Enable Time $\overline{\text{OE}}$ to O _n	5.0	2.0	6.5	11.0	1.5	12.0	ns
t _{PHZ}	Output Disable Time $\overline{\text{OE}}$ to O _n	5.0	1.5	6.5	11.0	1.5	12.0	ns
t _{PLZ}	Output Disable Time $\overline{\text{OE}}$ to O _n	5.0	1.5	6.0	10.5	1.5	11.5	ns

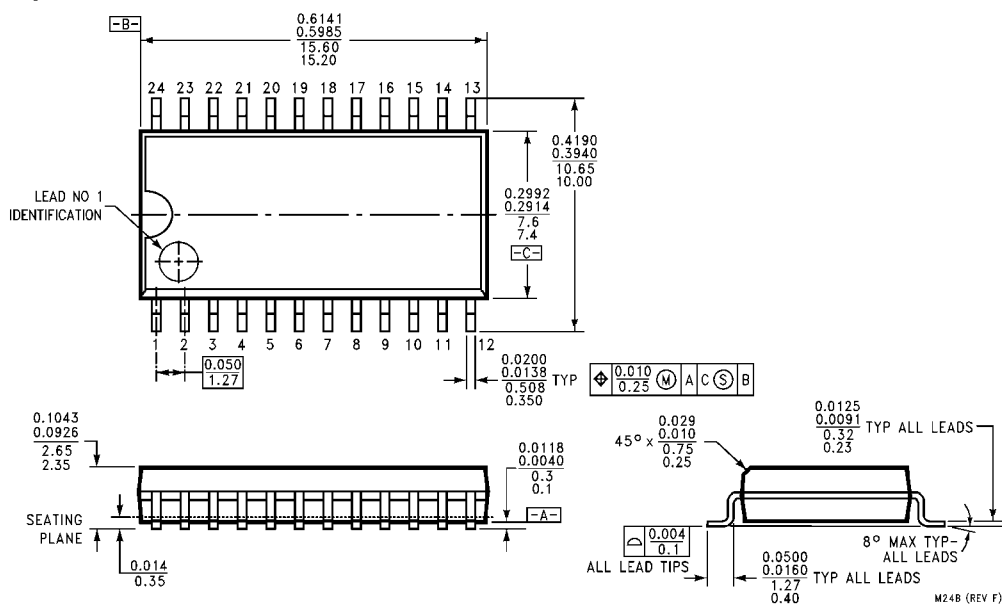
Note 4: Voltage Range 5.0 is 5.0V ±0.5V

AC Operating Requirements							
Symbol	Parameter	V _{CC} (V) (Note 5)	T _A = +25°C, C _L = 50 pF		T _A = -40°C to +85°C C _L = 50 pF		Units
			Typ	Guaranteed Minimum			
t _S	Setup Time, HIGH or LOW D to CP	5.0	0.5	2.5	2.5		ns
t _H	Hold Time, HIGH or LOW D _n to CP	5.0	0	2.5	2.5		ns
t _S	Setup Time, HIGH or LOW $\overline{\text{EN}}$ to CP	5.0	0	2.0	2.5		ns
t _H	Hold Time, HIGH or LOW $\overline{\text{EN}}$ to CP	5.0	0	1.0	1.0		ns
t _W	CP Pulse Width HIGH or LOW	5.0	2.5	4.5	5.5		ns
t _W	$\overline{\text{CLR}}$ Pulse Width, LOW	5.0	3.0	5.5	5.5		ns
t _{rec}	$\overline{\text{CLR}}$ to CP Recovery Time	5.0	1.5	3.5	4.0		ns

Note 5: Voltage Range 5.0 is 5.0V ±0.5V

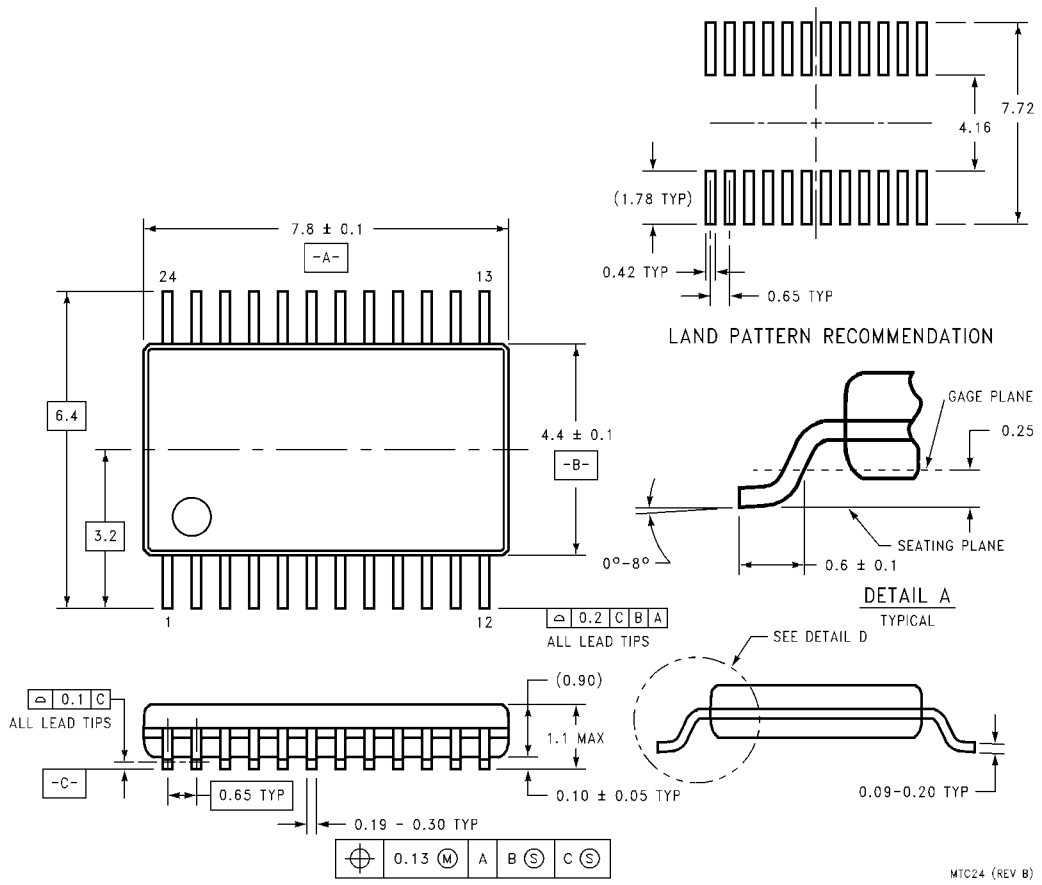
Capacitance					
Symbol	Parameter	Typ	Units	Conditions	
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = OPEN	
C _{PD}	Power Dissipation Capacitance	44	pF	V _{CC} = 5.0V	

Physical Dimensions inches (millimeters) unless otherwise noted



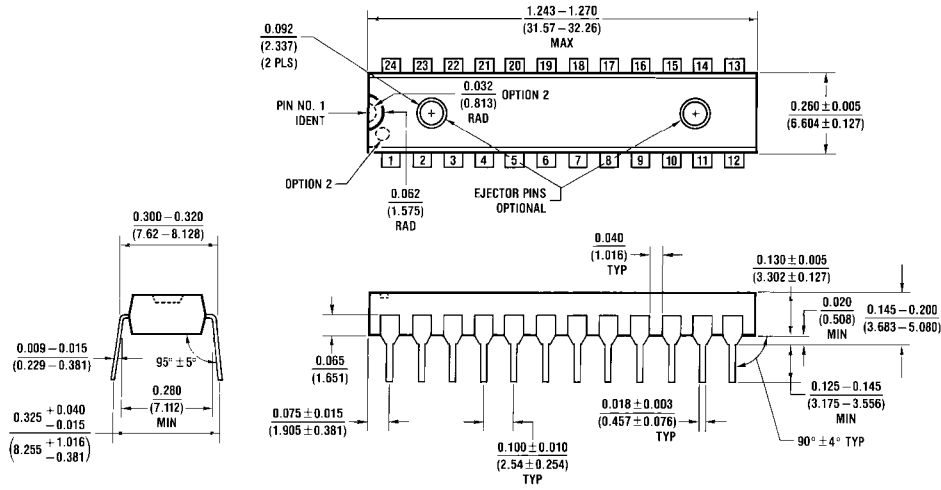
**24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide Body
Package Number M24B**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



**24-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
Package Number MTC24**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



N24C (REV F)

**24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-100, 0.300" Wide
Package Number N24C**

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